Dielectric Performance for Electronic Applications using UV-Curable Chemistries
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Abstract
UV-curable electronic materials require a unique set of expertise in resin formulation, processing, and end-use properties. Commercial uses for UV-curable electronic products include conformal coatings, potting, photoresists, display materials, adhesives, as well as various 3D printing applications. This paper will focus on using dielectric testing techniques to quantify a wide range of electronics resins for these growing applications.

Introduction
Dielectric performance is highly important for a variety of electronic applications. It controls how the material reacts under electric field and/or a change in frequency. Temperature, humidity, mechanical forces, surface structure, defects, and porosity can affect the resultant dielectric properties.

Capacitor film has been an area of interest for UV curable materials due to their self-healing properties. Much work has been performed in this area around the development of high temperature thermoplastic films, which are capable of functioning as a DC-link capacitor for hybrid electric vehicles featuring wide band gap semiconductors \(^{I,II,III}\). Acrylate-based self-healing layers are known in the capacitor film space, but are limited by high temperature performance and are typically highly polar. New materials are being evaluated in this space based on dielectric performance versus frequency as well as high breakdown strength.

Ultra low loss materials for dielectric coatings is another application area of interest for UV curable materials. These materials can be used as dielectric layers to minimize their effect as a substrate when exposed to changing frequencies or high electric fields. Most commonly, they are used as insulating layers for multi-layer circuits.

Damping materials are widely sought after for sound and vibration elimination for a variety of applications. Damping materials related to electronics include optical camera image stabilization modules, microphones and speakers, shock absorption, displays, robotics, and motor/compressor noise. Silicone based UV curable materials are optimal for these applications but a recent focus on insulating acrylate based material systems will be considered.

UV curable potting materials are useful in applications that require shallow depth of cure (typically up to 0.25 inches), have temperature sensitive components, and need a fast, in-line production process. They also feature nearly unlimited working times compared to conventionally thermally cured systems if kept in a dark environment. UV-curable potting materials typically make a rigid bond with excellent adhesion to plastics with good chemical resistance and excellent insulation properties.

Experimental Setup
Film samples were conditioned prior to testing by heating to approximately 25°C below the material’s glass transition temperature (Tg) to remove any absorbed moisture. Cured film thickness
was measured using a Heidenhain Metro gauge accurate to ± 0.2 µm. Three locations in a 1.0 cm² area were chosen for film thicknesses measurement prior to screen printing of conductive ink and their average was used for the dielectric constant and volume resistivity calculations.

Breakdown strength of cured films was measured using the ASTM D-149 standard, ramping at 500 V/s. This test utilizes a 6.35 mm stainless steel ball on a brass substrate in 25°C silicone oil to minimize the electric field non-uniformity and the chances of a film defect being present at the test location. The cured film thickness was measured and recorded in each breakdown location prior to breakdown. Twenty measurements were made on each film and the dataset was fit using a 2-parameter Weibull distribution with a 95% confidence interval.

Dielectric Constant and Loss was measured using an LCR meter at room temperature via the ASTM D-150 standard. One side electrode of the capacitor was connected to high voltage and high current terminal of LCR meter and the other electrode of the capacitor was connected to a low voltage and low current terminal. A 2 VAC bias was applied to each sample during the measurement.

Surface and Volume Resistivity was measured using a Keithley 6517B and 8009 fixture at room temperature via the ASTM D-257 standard. An alternating polarity of ±100 V was applied to the cured film for 10 seconds with a 2nA current range prior to measurement to ensure a net zero charge.

**Results and Discussion**

Two monomers have been analyzed specifically for use in the capacitor film coating application. Monomer 1 is a conventional off the shelf material with good thermal and mechanical performance from -40-150C. Monomer 2 is an optimization of Monomer one that statistically decreases the dielectric loss at higher frequencies and only slightly decreases the dielectric constant of the material over the 20Hz-1MHz operation range. As SiC MOSFETs and IGBTs become more prevalent on the market due to a decrease on-state resistance, their wide band-gap performance has necessitated a higher operational temperature and frequency. Understanding how to modify the chemistry of the monomers to decrease the dielectric loss of the materials at high frequency is of utmost importance for optimal material down selection. Figure (A) below shows Monomer 1 and 2 having the same trend in dielectric constant vs. frequency as measured with the LCR meter. Figure (B) outlines a similar performance at low frequencies with a statistical difference present above 1kHz.
Figure 1. (A) Shows Monomer 1 and 2 having the same trend in dielectric constant vs. frequency as measured with the LCR meter. Figure (B) outlines a similar dielectric loss performance at low frequencies with a statistical difference present above 1kHz.

Breakdown strength of Monomer 1 and 2 were measured using the ASTM D-149 standard as described in the Experimental section above. Figure 2 shows the results of the 2-parameter Weibull analysis at 25°C. A statistical difference in dielectric breakdown strength can be seen with Monomer 2 having approximately 100V/µm greater dielectric strength.
Figure 2. Shows the breakdown strength of Monomer 1 and 2. The Shape parameter describes how the Weibull data is distributed. The Scale parameter determines the spread of the Weibull distribution. The Anderson-Darling statistic (denoted AD*) measures the area between the Weibull distribution line of best fit and the empirical distribution function from the individual data points.

Optimization of dielectric loss is a key factor in many applications like dielectric substrates, device encapsulation, thermoset film capacitors and potting materials. New hydrophobic resin blends have been developed to optimize the low loss needs of these applications while still maintaining good breakdown strength characteristics. Humidity strongly affects the dielectric materials that are hydrophilic, and can increase capacitance and loss significantly at 85% relative humidity. When fillers are added to the matrix to increase dielectric constant and not change dielectric loss without functionalization of the particles, detrimental effects typically occur by a drastic reduction in the shape and scale parameters of the Weibull breakdown results. Figure 3 shows 3 new resins blends that have been developed that significant reduce the dielectric loss of the material while keeping the dielectric constant stable versus frequency.
All 3 resin blends show differences in dielectric constant and loss over the 20Hz to 1MHz range. Blend 1 has the highest dielectric constant with a good average dielectric loss over the range of frequencies. A high dielectric constant is preferred in most applications as this can increase the capacitance for the same film thickness. Blend 2 shows the lowest dielectric constant versus frequency and lowest dielectric loss up to 100kHz before trending higher. Blend 3 shows a dielectric constant of 2.65-2.8 with very low loss at 1MHz that is continuing to trend lower. For higher frequency applications, this would be the preferred blend based on its dielectric performance.

Damping behavior is governed by the orientational polarization of the material (called the dipole moment). Materials with a high dipole moment are well correlated with their respective mechanical loss factors and shear compliance values\(^7\). Oligomer 1 and Monomer Blend 1 shown in Figure 4 are good examples of acrylate based polar resins that have high dielectric loss and excellent damping behavior over a wide range of frequencies. As seen in Figure 4, Monomer Blend 1 has a larger variation due to the limited adhesion of the screen printed conductive ink in all of the samples. Oligomer 1 is a much harder material compared to Monomer Blend 1, which allows for better adhesion of the conductive ink.
Ultra hydrophobic UV potting resins have been developed to work at a wide range of temperatures, have high volume resistivity, and high breakdown strength while maintaining good thermal and mechanical shock resistance. In certain applications, a thermally cured potting solution could damage temperature sensitive electronic components. Figure 5A shows the room temperature Breakdown strength of a Resin Blend 1 and 2 with a target viscosity of 5kcPs for easy application in a manufacturing environment. High breakdown strength values of 580-654 V/µm with high shape factors indicate great dielectric strength and high repeatability. Figure 5B shows the relationship between surface and volume resistivity, which are important factors in determining how good of an insulator the respective blends are as a function of voltage. The higher the values of surface and volume resistivity, the better the insulator is at isolating voltage under electric field.

Figure 4. Shows the dielectric loss (loss tangent) spectrum as a function of frequency and material composition at 25°C
Figure 5. (A) Shows the ASTM D-149 breakdown strength of Resin Blend 1 and 2. The Shape parameter describes how the Weibull data is distributed. The Scale parameter determines the spread of the Weibull distribution. The Anderson-Darling statistic (denoted $AD^*$) measures the area between the Weibull distribution line of best fit and the empirical distribution function from the individual data points. Figure (B) outlines the surface vs. volume resistivity at 25°C using the ASTM D-257 Standard.

Conclusion
Herein we have identified next generation materials that are capable of being optimized for each respective application. Cured resins have been showcased for examples in capacitor film coatings, low loss dielectrics, audio/vibration damping, and UV curable potting materials. The common themes of these materials include the need for high breakdown strength, low moisture uptake, very low or very high dielectric constant and high resistivity values. These examples of new materials show how electronic properties can be optimized specific for an application by optimizing the chemistry of the resin.

References
\footnote{Fan, Baoyan et al. “Dielectric materials for high-temperature capacitors.” (2018).}